



## UNITED STATES PATENT AND TRADEMARK OFFICE

UNITED STATES DEPARTMENT OF COMMERCE  
 United States Patent and Trademark Office  
 Address: COMMISSIONER FOR PATENTS  
 P.O. Box 1450  
 Alexandria, Virginia 22313-1450  
 www.uspto.gov



Bib Data Sheet

CONFIRMATION NO. 1763

SERIAL NUMBER 10/750,443	FILING DATE 12/30/2003  RULE	CLASS 438	GROUP ART UNIT 2818	ATTORNEY DOCKET NO. 4717-8300
-----------------------------	---------------------------------------	--------------	------------------------	-------------------------------------

APPLICANTS

Eric Neyret, Sassenage, FRANCE;  
 Ludovic Ecarnot, Varcès, FRANCE;

\*\* CONTINUING DATA ..... *YES PD*  
 This application is a CON of PCT/FR02/02341 07/04/2002

\*\* FOREIGN APPLICATIONS ..... *YES PD*  
 FRANCE 0108859 07/04/2001

IF REQUIRED, FOREIGN FILING LICENSE GRANTED  
 \*\* 05/03/2004

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY FRANCE	SHEETS DRAWING 1	TOTAL CLAIMS 20	INDEPENDENT CLAIMS 2
35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance	Verified and Acknowledged	<i>Signature</i> Examiner's Signature	<i>PD</i> Initials	

ADDRESS  
 28765  
 WINSTON & STRAWN  
 PATENT DEPARTMENT  
 1400 L STREET, N.W.  
 WASHINGTON, DC  
 20005-3502

TITLE  
 Method for reducing free surface roughness of a semiconductor wafer

FILING FEE	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time )
------------	---	--